

EL7182C

2-Phase, High Speed CCD Driver

Features

- 3V and 5V Input compatible
- Clocking speeds up to 10 MHz
- Reduced clock skew
- 20 ns Switching/delay time
- 2A Peak drive
- Low quiescent current
- Wide operating voltage— 4.5V-16V

Applications

- CCD Drivers requiring highcontrast imaging
- Differential line drivers
- Push-pull circuits

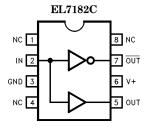
Ordering Information

Part No.	Temp. R	ange	Pkg.	Outline	#
EL7182CN	−40°C to	+ 85°C 8-	Pin P-DIP	MDP003	31
EL7182CS	−40°C to	+ 85°C 8-	Pin SO	MDP002	27

General Description

The EL7182C is extremely well suited for driving CCD's, especially where high contrast imaging is desirable. The 16V supply rating is attractive for higher voltage CCD applications, as in color fax machines. The input is TTL and 3V compatible. The low quiescent current requirement is advantageous in portable/battery powered systems. The EL7182 is available in 8-pin P-DIP and 8-lead SO packages.

Connection Diagram



7182-1

Manufactured under U.S. Patent Nos. 5,334,883, #5,341,047

EL7182C

2-Phase, High Speed CCD Driver

Absolute Maximum Ratings

Supply (V+ to Gnd) 16.5V Operating Junction Temperature 125°C

Input Pins -0.3V to +0.3V above V^+ Power Dissipation

Combined Peak Output Current 4A SOIC 570 mW
Storage Temperature Range -65°C to +150°C PDIP 1050 mW

Storage Temperature Range -65° C to $+150^{\circ}$ C PDIP Ambient Operating Temperature -40° C to $+85^{\circ}$ C

Important Note:

All parameters having Min/Max specifications are guaranteed. The Test Level column indicates the specific device testing actually performed during production and Quality inspection. Elantec performs most electrical tests using modern high-speed automatic test equipment, specifically the LTX77 Series system. Unless otherwise noted, all tests are pulsed tests, therefore $T_J = T_C = T_A$.

Test Level Test Procedure

 $\begin{tabular}{ll} I&100\%&production tested and QA sample tested per QA test plan QCX0002.\\ II&100\%&production tested at $T_A=25^\circ$C and QA sample tested at $T_A=25^\circ$C$,} \end{tabular}$

 $T_{
m MAX}$ and $T_{
m MIN}$ per QA test plan QCX0002.

III QA sample tested per QA test plan QCX0002.IV Parameter is guaranteed (but not tested) by Design and Cha

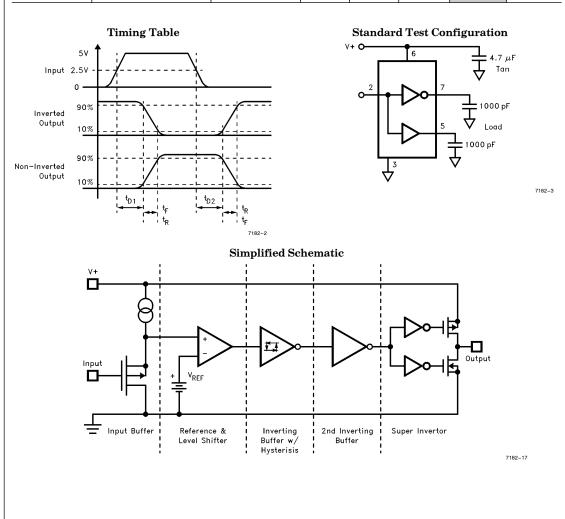
 $\begin{array}{ll} IV & \text{Parameter is guaranteed (but not tested) by Design and Characterization Data.} \\ V & \text{Parameter is typical value at $T_A=25^{\circ}$C for information purposes only.} \end{array}$

DC Electrical Characteristics $T_A = 25$ °C, V = 15V unless otherwise specified

Parameter	Description	Test Conditions	Min	Тур	Max	Test Level	Units
Input							
V_{IH}	Logic "1" Input Voltage		2.4			I	v
I_{IH}	Logic "1" Input Current	@V+		0.1	10	I	μΑ
$v_{\rm IL}$	Logic "0" Input Voltage				0.8	I	v
I _{IL}	Logic "0" Input Current	@0V		0.1	10	I	μΑ
V _{HVS}	Input Hysteresis			0.3		v	v
Output			•				
R _{OH}	Pull-Up Resistance	$I_{OUT} = -100 \text{ mA}$		3	6	I	Ω
R _{OL}	Pull-Down Resistance	$I_{OUT} = +100 \text{ mA}$		4	6	I	Ω
$I_{ m PK}$	Peak Output Current	Source Sink		2 2		IV	A
I _{DC}	Continuous Output Current	Source/Sink	100			I	mA
Power Supply							
I_S	Power Supply Current	Input High		2.5	5	I	mA
V _S	Operating Voltage		4.5		16	I	v

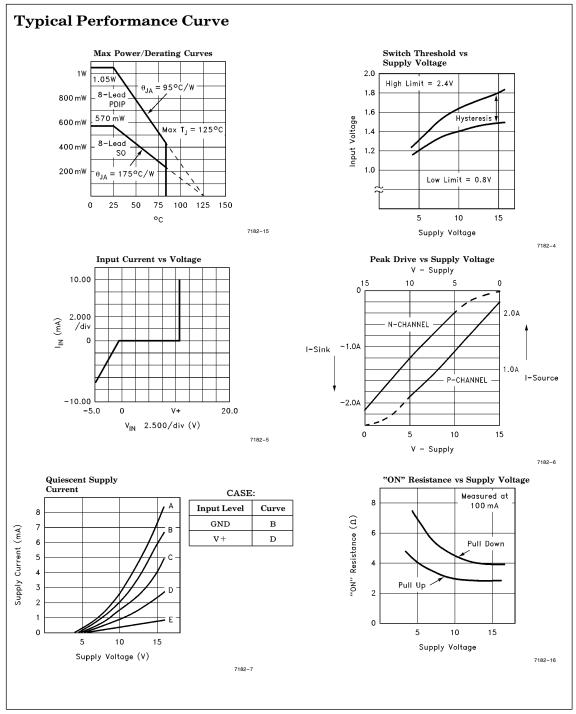
EL7182C 2-Phase, High Speed CCD Driver

AC Electrical Characteristics T _A = 25°C, V = 15V unless otherwise specified								
Parameter	Description	Test Conditions	Min	Тур	Max	Test Level	Units	
Switching Chara	cteristics							
t _R	Rise Time	$C_{ m L} = 500 \ m pF$ $C_{ m L} = 1000 \ m pF$		7.5 10	20	IV	ns	
t _F	Fall Time	$C_{L} = 500 \text{ pF}$ $C_{L} = 1000 \text{ pF}$		10 13	20	IV	ns	
t _{D-ON}	Turn-On Delay Time			18	25	IV	ns	
t _{D-OFF}	Turn-Off Delay Time			20	25	IV	ns	



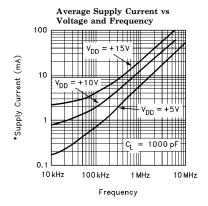
EL7182C

2-Phase, High Speed CCD Driver

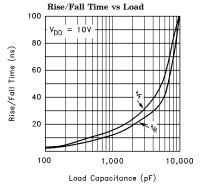


EL7182C 2-Phase, High Speed CCD Driver

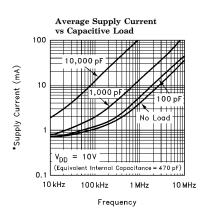
Typical Performance Curve — Contd.



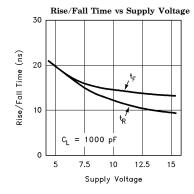
7182-8



7182_14



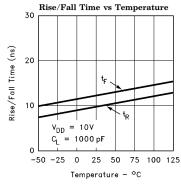
7182-9

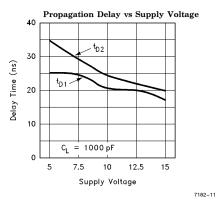


7182-10

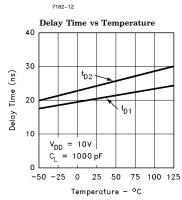
EL7182C 2-Phase, High Speed CCD Driver

Typical Performance Curve — Contd.





7182-13



General Disclaimer

Specifications contained in this data sheet are in effect as of the publication date shown. Elantec, Inc. reserves the right to make changes in the circuitry or specifications contained herein at any time without notice. Elantec, Inc. assumes no responsibility for the use of any circuits described herein and makes no representations that they are free from patent infringement.



Elantec, Inc. 1996 Tarob Court Milpitas, CA 95035

Telephone: (408) 945-1323

(800) 333-6314 Fax: (408) 945-9305

European Office: 44-71-482-4596

WARNING — Life Support Policy

Elantec, Inc. products are not authorized for and should not be used within Life Support Systems without the specific written consent of Elantec, Inc. Life Support systems are equipment intended to support or sustain life and whose failure to perform when properly used in accordance with instructions provided can be reasonably expected to result in significant personal injury or death. Users contemplating application of Elantec, Inc. products in Life Support Systems are requested to contact Elantec, Inc. factory headquarters to establish suitable terms & conditions for these applications. Elantec, Inc.'s warranty is limited to replacement of defective components and does not cover injury to persons or property or other consequential damages.

January 1996 Rev. B